

# LM4766 *Overture*™ Audio Power Amplifier Series Dual 40W Audio Power Amplifier with Mute

Check for Samples: LM4766

#### **FEATURES**

- SPiKe Protection
- Minimal Amount of External Components Necessary
- Quiet Fade-In/Out Mute Mode
- Non-Isolated 15-Lead TO-220 Package
- Wide Supply Range 20V 78V

#### **APPLICATIONS**

- High-End Stereo TVs
- Component Stereo
- Compact Stereo

#### **KEY SPECIFICATIONS**

- THD+N at 1kHz at 2 x 30W Continuous Average Output Power Into 8Ω 0.1% (Max)
- THD+N at 1kHz at Continuous Average Output Power of 2 x 30W Into 8Ω 0.009% (Typ)

#### DESCRIPTION

The LM4766 is a stereo audio amplifier capable of delivering typically 40W per channel with the non-isolated "NDL" package and 30W per channel with the isolated "NDB" package of continuous average output power into an  $8\Omega$  load with less than 0.1% (THD+N).

The performance of the LM4766, utilizing its Self Peak Instantaneous Temperature (°Ke) (SPiKe) Protection Circuitry, places it in a class above discrete and hybrid amplifiers by providing an inherently, dynamically protected Safe Operating Area (SOA). **SPiKe** Protection means that these parts are safeguarded at the output against overvoltage, undervoltage, overloads, including thermal runaway and instantaneous temperature peaks.

Each amplifier within the LM4766 has an independent smooth transition fade-in/out mute that minimizes output pops. The IC's extremely low noise floor at  $2\mu V$  and its extremely low THD+N value of 0.06% at the rated power make the LM4766 optimum for highend stereo TVs or minicomponent systems.

#### **Connection Diagram**

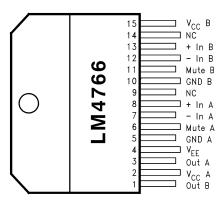


Figure 1. Plastic Package
Top View
Non-Isolated TO-220 Package
See Package Number NDL0015A
Isolated PFM Package
See Package Number NDB0015B

A

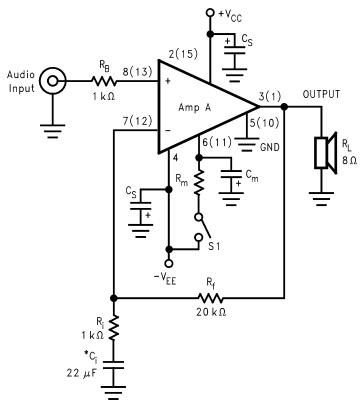
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

Overture is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.



# **Typical Application**



Numbers in parentheses represent pinout for amplifier B.

Figure 2. Typical Audio Amplifier Application Circuit

<sup>\*</sup>Optional component dependent upon specific design requirements.





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### ABSOLUTE MAXIMUM RATINGS (1) (2) (3)

O		(No Input)	78V			
Supply Voltage  V <sub>CC</sub>   +  V <sub>EE</sub>		(with Input)	74V			
Common Mode Input Voltage	$(V_{CC} \text{ or } V_{EE}) \text{ and }$ $ V_{CC}  +  V_{EE}  \le 60V$					
Differential Input Voltage			60V			
Output Current	Internally Limited					
Power Dissipation (4)	62.5W					
ESD Susceptibility (5)	3000V					
Junction Temperature (6)	Junction Temperature <sup>(6)</sup>					
Thermal Resistance	Non-Isolated NDL-Package	$\theta_{JC}$	1°C/W			
	Isolated NDB-Package	$\theta_{JC}$	2°C/W			
Soldering Information		NDL and NDB Packages	260°C			
Storage Temperature			-40°C to +150°C			

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given, however, the typical value is a good indication of device performance.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (3) All voltages are measured with respect to the GND pins (5, 10), unless otherwise specified.
- (4) For operating at case temperatures above 25°C, the device must be derated based on a 150°C maximum junction temperature and a thermal resistance of θ<sub>JC</sub> = 1°C/W (junction to case) for the NDL package. Refer to the section DETERMINING THE CORRECT HEAT SINK in the APPLICATION INFORMATION section.
- (5) Human body model, 100pF discharged through a 1.5kΩ resistor.
- (6) The operating junction temperature maximum is 150°C, however, the instantaneous Safe Operating Area temperature is 250°C.

## OPERATING RATINGS (1) (2)

Temperature Range	$T_{MIN} \le T_A \le T_{MAX}$	-20°C ≤ T <sub>A</sub> ≤ +85°C
Supply Voltage  V <sub>CC</sub>   +  V <sub>EE</sub>   (3)		20V to 60V

- (1) All voltages are measured with respect to the GND pins (5, 10), unless otherwise specified.
- (2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given, however, the typical value is a good indication of device performance.
- (3) Operation is ensured up to 60V, however, distortion may be introduced from **SPiKe** Protection Circuitry if proper thermal considerations are not taken into account. Refer to the APPLICATION INFORMATION section for a complete explanation.



# **ELECTRICAL CHARACTERISTICS (1) (2)**

The following specifications apply for  $V_{CC} = +30V$ ,  $V_{EE} = -30V$ ,  $I_{MUTE} = -0.5 mA$  with  $R_L = 8\Omega$  unless otherwise specified. Limits apply for  $T_A = 25$ °C.

Symbol	Parameter	Conditions	LM4	Units	
			Typical <sup>(3)</sup>	Limit (4)	(Limits)
D/ 1 . D/ 1	Danier Complex Voltage (5)	CND V > 0V	40	20	V (min)
$ V_{CC}  +  V_{EE} $	Power Supply Voltage (5)	GND - V <sub>EE</sub> ≥ 9V	18	60	V (max)
P <sub>O</sub> <sup>(6)</sup> <sup>(7)</sup>	Output Power (Continuous	NDL Package, $V_{CC} = \pm 30V$ , THD+N = 0.1% (max), f = 1kHz, f = 20kHz	40	30	W/ch (min)
	Average)	NDB Package, $V_{CC} = \pm 26V^{(7)}$ , THD+N = 0.1% (max), f = 1kHz, f = 20kHz	30	25	W/ch (min)
THD+N	Total Harmonic Distortion	NDL Package, 30W/ch, $R_L = 8\Omega$ , $20Hz \le f \le 20kHz$ , $A_V = 26dB$	0.06		%
	Plus Noise	NDB Package, 25W/ch, $R_L = 8\Omega$ , $20Hz \le f \le 20kHz$ , $A_V = 26dB$	0.06		%
X <sub>talk</sub>	Channel Separation	$f = 1kHz$ , $V_O = 10.9Vrms$	60		dB
SR <sup>(6)</sup>	Slew Rate	V <sub>IN</sub> = 1.2Vrms, t <sub>rise</sub> = 2ns	9	5	V/µs (min)
I <sub>total</sub> (8)	Total Quiescent Power Supply Current	Both Amplifiers $V_{CM} = 0V$ , $V_{O} = 0V$ , $I_{O} = 0mA$	48	100	mA (max)
V <sub>OS</sub> <sup>(8)</sup>	Input Offset Voltage	$V_{CM} = 0V, I_O = 0mA$	1	10	mV (max)
I <sub>B</sub>	Input Bias Current	$V_{CM} = 0V$ , $I_O = 0mA$	0.2	1	μA (max)
I <sub>os</sub>	Input Offset Current	$V_{CM} = 0V, I_O = 0mA$	0.01	0.2	μA (max)
Io	Output Current Limit	$ V_{CC}  =  V_{EE}  = 10V$ , $t_{ON} = 10$ ms, $V_{O} = 0V$	4	3	Apk (min)
V (8)	Output Proposit Voltage (9)	$ V_{CC}-V_{O} $ , $V_{CC} = 20V$ , $I_{O} = +100mA$	1.5	4	V (max)
V <sub>OD</sub> (8)	Output Dropout Voltage (9)	$ V_O-V_{EE} $ , $V_{EE} = -20V$ , $I_O = -100$ mA	2.5	4	V (max)
PSRR <sup>(8)</sup>	Barrer Ormala Baile dia a Baile	$V_{CC}$ = 30V to 10V, $V_{EE}$ = -30V, $V_{CM}$ = 0V, $I_{O}$ = 0mA	125	85	dB (min)
	Power Supply Rejection Ratio	$V_{CC} = 30V$ , $V_{EE} = -30V$ to $-10V$ $V_{CM} = 0V$ , $I_{O} = 0$ mA	110	85	dB (min)
CMRR <sup>(8)</sup>	Common Mode Rejection Ratio	$V_{CC} = 50V$ to 10V, $V_{EE} = -10V$ to -50V, $V_{CM} = 20V$ to -20V, $I_{O} = 0$ mA	110	75	dB (min)
A <sub>VOL</sub> <sup>(8)</sup>	Open Loop Voltage Gain	$R_L = 2k\Omega$ , $\Delta V_O = 40V$	115	80	dB (min)
GBWP	Gain Bandwidth Product	f <sub>O</sub> = 100kHz, V <sub>IN</sub> = 50mVrms	8	2	MHz (min)
e <sub>IN</sub> <sup>(6)</sup>	Input Noise	IHF–A Weighting Filter, $R_{IN} = 600\Omega$ (Input Referred)	2.0	8	μV (max)
CND	Signal to Naigo Potio	$P_{O}$ = 1W, A–Weighted, Measured at 1kHz, $R_{S}$ = 25 $\Omega$	98		dB
SNR	Signal-to-Noise Ratio	$P_{O}$ = 25W, A–Weighted Measured at 1kHz, $R_{S}$ = 25 $\Omega$	112		dB
A <sub>M</sub>	Mute Attenuation	Pin 6,11 at 2.5V	115	80	dB (min)

- (1) All voltages are measured with respect to the GND pins (5, 10), unless otherwise specified.
- (2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given, however, the typical value is a good indication of device performance.
- (3) Typicals are measured at 25°C and represent the parametric norm.
- (4) Limits are specifications that all parts are tested in production to meet the stated values.
- (5) V<sub>EE</sub> must have at least -9V at its pin with reference to ground in order for the under-voltage protection circuitry to be disabled. In addition, the voltage differential between V<sub>CC</sub> and V<sub>EE</sub> must be greater than 14V.
- (6) AC Electrical Test; Refer to Test Circuit #2.
- (7) When using the isolated package (NDB), the θ<sub>JC</sub> is 2°C/W verses 1°C/W for the non-isolated package (NDL). This increased thermal resistance from junction to case requires a lower supply voltage for decreased power dissipation within the package. Voltages higher than ±26V maybe used but will require a heat sink with less than 1°C/W thermal resistance to avoid activating thermal shutdown during normal operation.
- (8) DC Electrical Test; Refer to Test Circuit #1.
- (9) The output dropout voltage, V<sub>OD</sub>, is the supply voltage minus the clipping voltage. Refer to the Clipping Voltage vs. Supply Voltage graph in the TYPICAL PERFORMANCE CHARACTERISTICS section.

Submit Documentation Feedback

Copyright © 1998–2013, Texas Instruments Incorporated



## **Test Circuit #1**

(DC Electrical Test Circuit)

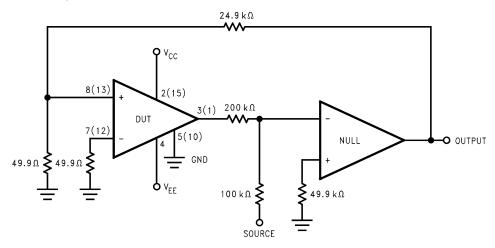


Figure 3.

# **Test Circuit #2**

(AC Electrical Test Circuit)

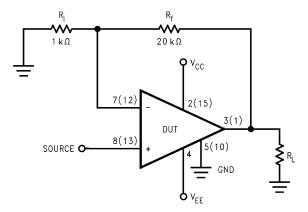


Figure 4.

Copyright © 1998–2013, Texas Instruments Incorporated



## **BRIDGED AMPLIFIER APPLICATION CIRCUIT**

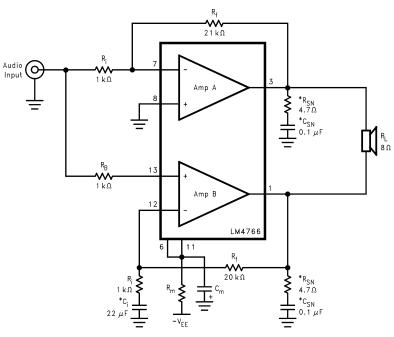
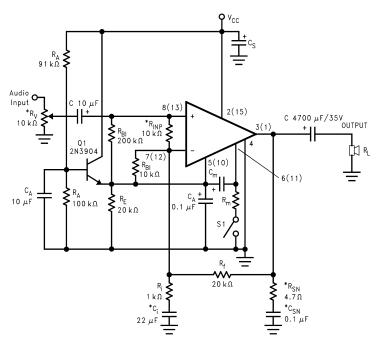


Figure 5. Bridged Amplifier Application Circuit

# **Single Supply Application Circuit**



<sup>\*</sup>Optional components dependent upon specific design requirements.

Figure 6. Single Supply Amplifier Application Circuit



# **Auxiliary Amplifier Application Circuit**

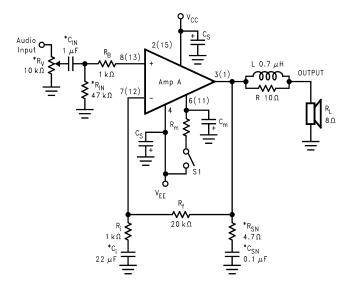
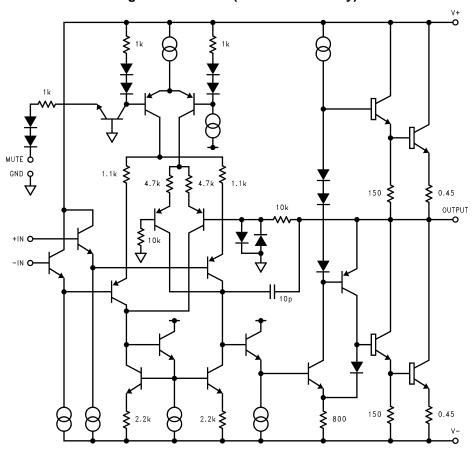


Figure 7. Special Audio Amplifier Application Circuit

# **Equivalent Schematic**

(excluding active protection circuitry)

Figure 8. LM4766 (One Channel Only)



Copyright © 1998–2013, Texas Instruments Incorporated



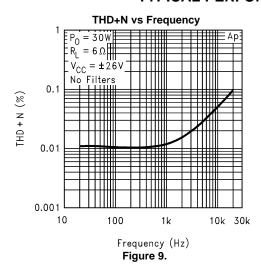
# **External Components Description**

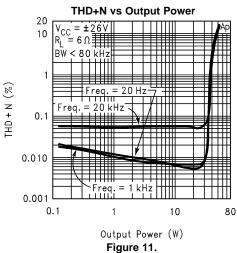
C	components	Functional Description
1	R <sub>B</sub>	Prevents currents from entering the amplifier's non-inverting input which may be passed through to the load upon power down of the system due to the low input impedance of the circuitry when the undervoltage circuitry is off. This phenomenon occurs when the supply voltages are below 1.5V.
2	R <sub>i</sub>	Inverting input resistance to provide AC gain in conjunction with R <sub>f</sub> .
3	R <sub>f</sub>	Feedback resistance to provide AC gain in conjunction with R <sub>i</sub> .
4	C <sub>i</sub> <sup>(1)</sup>	Feedback capacitor which ensures unity gain at DC. Also creates a highpass filter with $R_i$ at $f_C = 1/(2\pi R_i C_i)$ .
5	Cs	Provides power supply filtering and bypassing. Refer to the SUPPLY BYPASSING section for proper placement and selection of bypass capacitors.
6	R <sub>V</sub> <sup>(1)</sup>	Acts as a volume control by setting the input voltage level.
7	R <sub>IN</sub> <sup>(1)</sup>	Sets the amplifier's input terminals DC bias point when $C_{IN}$ is present in the circuit. Also works with $C_{IN}$ to create a highpass filter at $f_C = 1/(2\pi R_{IN}C_{IN})$ . Refer to Figure 7.
8	C <sub>IN</sub> <sup>(1)</sup>	Input capacitor which blocks the input signal's DC offsets from being passed onto the amplifier's inputs.
9	R <sub>SN</sub> <sup>(1)</sup>	Works with C <sub>SN</sub> to stabilize the output stage by creating a pole that reduces high frequency instabilities.
10	C <sub>SN</sub> <sup>(1)</sup>	Works with $R_{SN}$ to stabilize the output stage by creating a pole that reduces high frequency instabilities. The pole is set at $f_C = 1/(2\pi R_{SN}C_{SN})$ . Refer to Figure 7.
11 12	L <sup>(1)</sup>	Provides high impedance at high frequencies so that R may decouple a highly capacitive load and reduce the Q of the series resonant circuit. Also provides a low impedance at low frequencies to short out R and pass audio signals to the load. Refer to Figure 7.
13	R <sub>A</sub>	Provides DC voltage biasing for the transistor Q1 in single supply operation.
14	C <sub>A</sub>	Provides bias filtering for single supply operation.
15	R <sub>INP</sub> <sup>(1)</sup>	Limits the voltage difference between the amplifier's inputs for single supply operation. Refer to the CLICKS AND POPS application section for a more detailed explanation of the function of $R_{\text{INP}}$ .
16	R <sub>BI</sub>	Provides input bias current for single supply operation. Refer to the CLICKS AND POPS application section for a more detailed explanation of the function of R <sub>BI</sub> .
17	R <sub>E</sub>	Establishes a fixed DC current for the transistor Q1 in single supply operation. This resistor stabilizes the half-supply point along with $C_A$ .
18	R <sub>M</sub>	Mute resistance set up to allow 0.5mA to be drawn from pin 6 or 11 to turn the muting function off. $\rightarrow$ R <sub>M</sub> is calculated using: R <sub>M</sub> $\leq$ ( $ V_{EE}  - 2.6V$ )/I where I $\geq$ 0.5mA. Refer to the Mute Attenuation vs Mute Current curves in the TYPICAL PERFORMANCE CHARACTERISTICS section.
19	C <sub>M</sub>	Mute capacitance set up to create a large time constant for turn-on and turn-off muting.
20	S <sub>1</sub>	Mute switch that mutes the music going into the amplifier when opened.

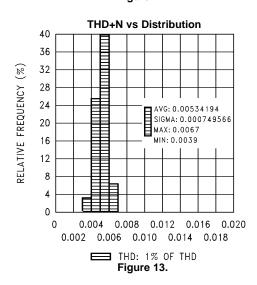
<sup>(1)</sup> Optional components dependent upon specific design requirements.

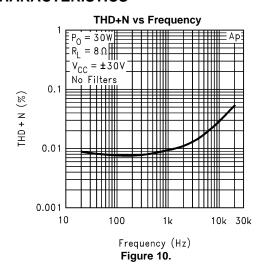


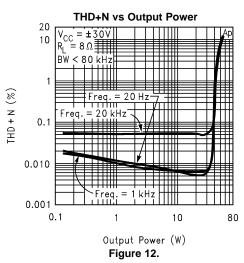
#### TYPICAL PERFORMANCE CHARACTERISTICS

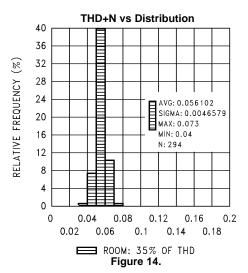




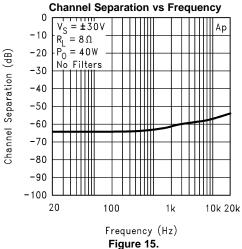


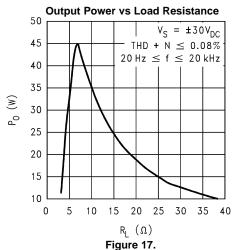












**Power Dissipation vs Output Power** 55  $= \pm 26 V_{-}$ 50 45 Power Dissipation (W) 40 35 ±20V 30 25 20 15  $\mathsf{R}_\mathsf{L}$  $= 6 \Omega$ 10 = 1 kHzTHD < 0.1% 5 0 25 0 5 10 15 20 30 35 Output Power (W) Figure 19.

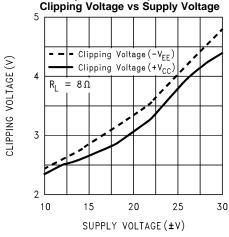
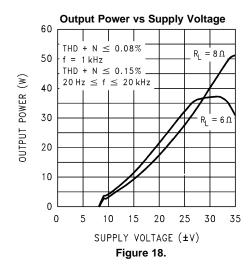


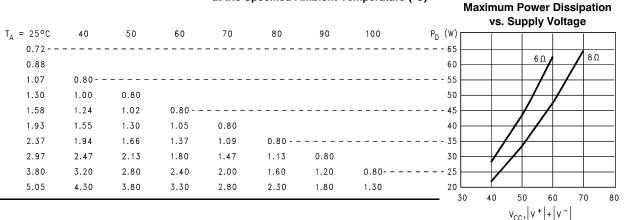
Figure 16.



**Power Dissipation vs Output Power** 55 = ±30V 50 45 Power Dissipation (W) 40 35 30 25 20  $= \pm 20 V$ 15  $R_L$  $\Omega 8 =$ 10 f = 1 kHz5 THD < 0.1% 0 10 15 20 25 35 40 0 5 30 Output Power (W) Figure 20.

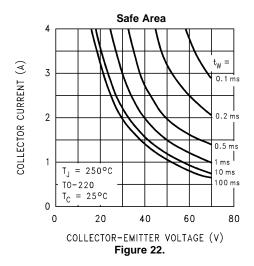


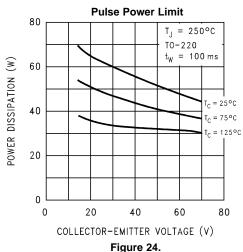
Max Heatsink Thermal Resistance (°C/W) at the Specified Ambient Temperature (°C)

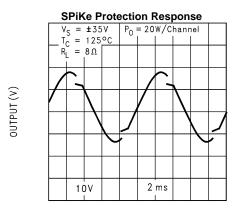


Note: The maximum heatsink thermal resistance values,  $\theta_{SA}$ , in the table above were calculated using a  $\theta_{CS} = 0.2^{\circ}\text{C/W}$  due to thermal compound.

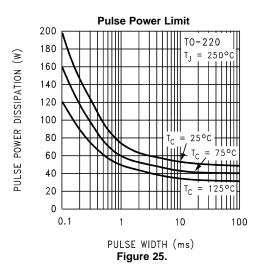
Figure 21.





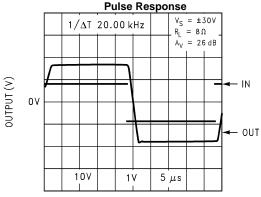


TIME (ms) Figure 23.



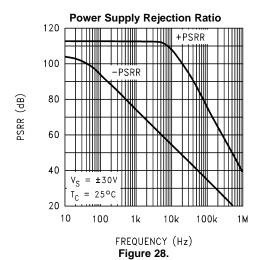
Copyright © 1998–2013, Texas Instruments Incorporated

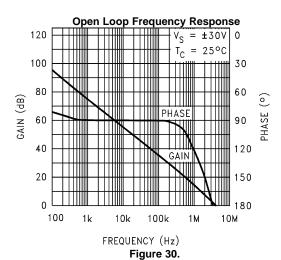




TIME  $(\mu s)$ 

Figure 26.





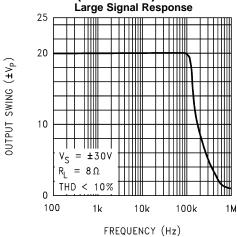
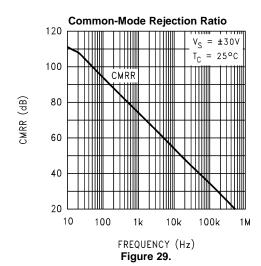


Figure 27.



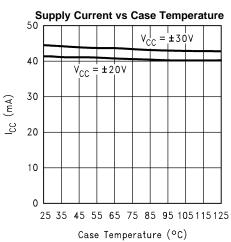
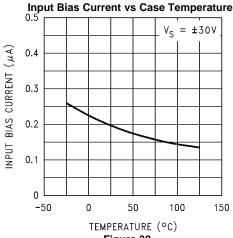
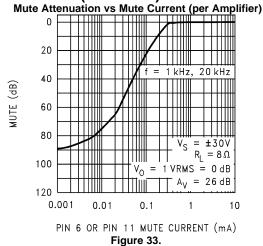


Figure 31.

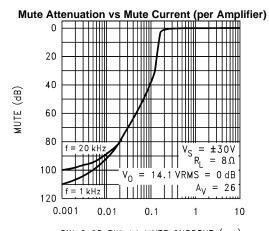








Output Power/Channel vs Supply Voltage f = 1kHz,  $R_L = 4\Omega$ , 80kHz BW



PIN 6 OR PIN 11 MUTE CURRENT (mA) Figure 34.

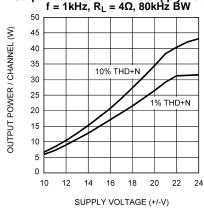


Figure 35.

# Output Power/Channel vs Supply Voltage $f = 1kHz, R_L = 6\Omega, 80kHz BW$

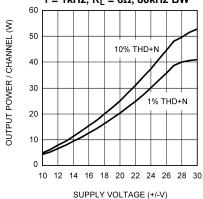
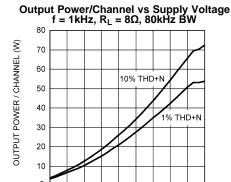


Figure 36.



19 22 25 28 SUPPLY VOLTAGE (+/-V)

13

16

10

Figure 37.

34 37



#### **APPLICATION INFORMATION**

#### **MUTE MODE**

The muting function of the LM4766 allows the user to mute the music going into the amplifier by drawing more than 0.5mA out of each mute pin on the device. This is accomplished as shown in the Typical Application Circuit where the resistor  $R_M$  is chosen with reference to your negative supply voltage and is used in conjunction with a switch. The switch when opened cuts off the current flow from pin 6 or 11 to  $-V_{EE}$ , thus placing the LM4766 into mute mode. Refer to the Mute Attenuation vs Mute Current curves in the TYPICAL PERFORMANCE CHARACTERISTICS section for values of attenuation per current out of pins 6 or 11. The resistance  $R_M$  is calculated by the following equation:

$$R_{M} \le (|-V_{EE}| - 2.6V)/I_{pin6}$$
 where 
$$\bullet \quad I_{pin6} = I_{pin11} \ge 0.5 mA.$$
 (1)

Both pins 6 and 11 can be tied together so that only one resistor and capacitor are required for the mute function. The mute resistance must be chosen such that greater than 1mA is pulled through the resistor  $R_M$  so that each amplifier is fully pulled out of mute mode. Taking into account supply line fluctuations, it is a good idea to pull out 1mA per mute pin or 2mA total if both pins are tied together.

#### UNDER-VOLTAGE PROTECTION

Upon system power-up, the under-voltage protection circuitry allows the power supplies and their corresponding capacitors to come up close to their full values before turning on the LM4766 such that no DC output spikes occur. Upon turn-off, the output of the LM4766 is brought to ground before the power supplies such that no transients occur at power-down.

#### **OVER-VOLTAGE PROTECTION**

The LM4766 contains over-voltage protection circuitry that limits the output current to approximately 4.0A<sub>PK</sub> while also providing voltage clamping, though not through internal clamping diodes. The clamping effect is quite the same, however, the output transistors are designed to work alternately by sinking large current spikes.

#### **SPIKe PROTECTION**

The LM4766 is protected from instantaneous peak-temperature stressing of the power transistor array. The Safe Operating graph in the TYPICAL PERFORMANCE CHARACTERISTICS section shows the area of device operation where **SPiKe** Protection Circuitry is not enabled. The waveform to the right of the SOA graph exemplifies how the dynamic protection will cause waveform distortion when enabled. Please refer to AN-898 for more detailed information.

#### THERMAL PROTECTION

The LM4766 has a sophisticated thermal protection scheme to prevent long-term thermal stress of the device. When the temperature on the die reaches 165°C, the LM4766 shuts down. It starts operating again when the die temperature drops to about 155°C, but if the temperature again begins to rise, shutdown will occur again at 165°C. Therefore, the device is allowed to heat up to a relatively high temperature if the fault condition is temporary, but a sustained fault will cause the device to cycle in a Schmitt Trigger fashion between the thermal shutdown temperature limits of 165°C and 155°C. This greatly reduces the stress imposed on the IC by thermal cycling, which in turn improves its reliability under sustained fault conditions.

Since the die temperature is directly dependent upon the heat sink used, the heat sink should be chosen such that thermal shutdown will not be reached during normal operation. Using the best heat sink possible within the cost and space constraints of the system will improve the long-term reliability of any power semiconductor device, as discussed in the DETERMINING THE CORRECT HEAT SINK section.

#### **DETERMINING MAXIMUM POWER DISSIPATION**

Power dissipation within the integrated circuit package is a very important parameter requiring a thorough understanding if optimum power output is to be obtained. An incorrect maximum power dissipation calculation may result in inadequate heat sinking causing thermal shutdown and thus limiting the output power.



Equation 2 exemplifies the theoretical maximum power dissipation point of each amplifier where  $V_{CC}$  is the total supply voltage.

$$P_{DMAX} = V_{CC}^2 / 2\pi^2 R_L \tag{2}$$

Thus by knowing the total supply voltage and rated output load, the maximum power dissipation point can be calculated. The package dissipation is twice the number which results from Equation 2 since there are two amplifiers in each LM4766. Refer to the graphs of Power Dissipation versus Output Power in the TYPICAL PERFORMANCE CHARACTERISTICS section which show the actual full range of power dissipation not just the maximum theoretical point that results from Equation 2.

#### **DETERMINING THE CORRECT HEAT SINK**

The choice of a heat sink for a high-power audio amplifier is made entirely to keep the die temperature at a level such that the thermal protection circuitry does not operate under normal circumstances.

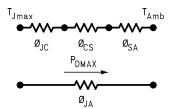
The thermal resistance from the die (junction) to the outside air (ambient) is a combination of three thermal resistances,  $\theta_{JC}$ ,  $\theta_{CS}$ , and  $\theta_{SA}$ . In addition, the thermal resistance,  $\theta_{JC}$  (junction to case), of the LM4766T is 1°C/W. Using Thermalloy Thermacote thermal compound, the thermal resistance,  $\theta_{CS}$  (case to sink), is about 0.2°C/W. Since convection heat flow (power dissipation) is analogous to current flow, thermal resistance is analogous to electrical resistance, and temperature drops are analogous to voltage drops, the power dissipation out of the LM4766 is equal to the following:

$$P_{DMAX} = (T_{JMAX} - T_{AMB})/\theta_{JA}$$

#### where

• T<sub>JMAX</sub> = 150°C, T<sub>AMB</sub> is the system ambient temperature

• 
$$\theta_{JA} = \theta_{JC} + \theta_{CS} + \theta_{SA}$$
 (3)



Once the maximum package power dissipation has been calculated using Equation 2, the maximum thermal resistance,  $\theta_{SA}$ , (heat sink to ambient) in °C/W for a heat sink can be calculated. This calculation is made using Equation 4 which is derived by solving for  $\theta_{SA}$  in Equation 3.

$$\theta_{SA} = [(T_{JMAX} - T_{AMB}) - P_{DMAX}(\theta_{JC} + \theta_{CS})]/P_{DMAX}$$
(4)

Again it must be noted that the value of  $\theta_{SA}$  is dependent upon the system designer's amplifier requirements. If the ambient temperature that the audio amplifier is to be working under is higher than 25°C, then the thermal resistance for the heat sink, given all other things are equal, will need to be smaller.

#### SUPPLY BYPASSING

The LM4766 has excellent power supply rejection and does not require a regulated supply. However, to improve system performance as well as eliminate possible oscillations, the LM4766 should have its supply leads bypassed with low-inductance capacitors having short leads that are located close to the package terminals. Inadequate power supply bypassing will manifest itself by a low frequency oscillation known as "motorboating" or by high frequency instabilities. These instabilities can be eliminated through multiple bypassing utilizing a large tantalum or electrolytic capacitor (10µF or larger) which is used to absorb low frequency variations and a small ceramic capacitor (0.1µF) to prevent any high frequency feedback through the power supply lines.

If adequate bypassing is not provided, the current in the supply leads which is a rectified component of the load current may be fed back into internal circuitry. This signal causes distortion at high frequencies requiring that the supplies be bypassed at the package terminals with an electrolytic capacitor of 470µF or more.



#### **BRIDGED AMPLIFIER APPLICATION**

The LM4766 has two operational amplifiers internally, allowing for a few different amplifier configurations. One of these configurations is referred to as "bridged mode" and involves driving the load differentially through the LM4766's outputs. This configuration is shown in Figure 5. Bridged mode operation is different from the classical single-ended amplifier configuration where one side of its load is connected to ground.

A bridge amplifier design has a distinct advantage over the single-ended configuration, as it provides differential drive to the load, thus doubling output swing for a specified supply voltage. Consequently, theoretically four times the output power is possible as compared to a single-ended amplifier under the same conditions. This increase in attainable output power assumes that the amplifier is not current limited or clipped.

A direct consequence of the increased power delivered to the load by a bridge amplifier is an increase in internal power dissipation. For each operational amplifier in a bridge configuration, the internal power dissipation will increase by a factor of two over the single ended dissipation. Thus, for an audio power amplifier such as the LM4766, which has two operational amplifiers in one package, the package dissipation will increase by a factor of four. To calculate the LM4766's maximum power dissipation point for a bridged load, multiply Equation 2 by a factor of four.

This value of  $P_{DMAX}$  can be used to calculate the correct size heat sink for a bridged amplifier application. Since the internal dissipation for a given power supply and load is increased by using bridged-mode, the heatsink's  $\theta_{SA}$  will have to decrease accordingly as shown by Equation 4. Refer to the section, DETERMINING THE CORRECT HEAT SINK for a more detailed discussion of proper heat sinking for a given application.

#### SINGLE-SUPPLY AMPLIFIER APPLICATION

The typical application of the LM4766 is a split supply amplifier. But as shown in Figure 6, the LM4766 can also be used in a single power supply configuration. This involves using some external components to create a half-supply bias which is used as the reference for the inputs and outputs. Thus, the signal will swing around half-supply much like it swings around ground in a split-supply application. Along with proper circuit biasing, a few other considerations must be accounted for to take advantage of all of the LM4766 functions, like the mute function.

#### **CLICKS AND POPS**

In the typical application of the LM4766 as a split-supply audio power amplifier, the IC exhibits excellent "click" and "pop" performance when utilizing the mute mode. In addition, the device employs Under-Voltage Protection, which eliminates unwanted power-up and power-down transients. The basis for these functions are a stable and constant half-supply potential. In a split-supply application, ground is the stable half-supply potential. But in a single-supply application, the half-supply needs to charge up just like the supply rail,  $V_{\rm CC}$ . This makes the task of attaining a clickless and popless turn-on more challenging. Any uneven charging of the amplifier inputs will result in output clicks and pops due to the differential input topology of the LM4766.

To achieve a transient free power-up and power-down, the voltage seen at the input terminals should be ideally the same. Such a signal will be common-mode in nature, and will be rejected by the LM4766. In Figure 6, the resistor  $R_{\text{INP}}$  serves to keep the inputs at the same potential by limiting the voltage difference possible between the two nodes. This should significantly reduce any type of turn-on pop, due to an uneven charging of the amplifier inputs. This charging is based on a specific application loading and thus, the system designer may need to adjust these values for optimal performance.

As shown in Figure 6, the resistors labeled  $R_{BI}$  help bias up the LM4766 off the half-supply node at the emitter of the 2N3904. But due to the input and output coupling capacitors in the circuit, along with the negative feedback, there are two different values of  $R_{BI}$ , namely  $10k\Omega$  and  $200k\Omega$ . These resistors bring up the inputs at the same rate resulting in a popless turn-on. Adjusting these resistors values slightly may reduce pops resulting from power supplies that ramp extremely quick or exhibit overshoot during system turn-on.



#### **AUDIO POWER AMPLIFIER DESIGN**

#### Design a 30W/8Ω Audio Amplifier

Given:

Power Output	30Wrms
Load Impedance	8Ω
Input Level	1Vrms(max)
Input Impedance	47kΩ
Bandwidth	20Hz-20kHz ±0.25dB

A designer must first determine the power supply requirements in terms of both voltage and current needed to obtain the specified output power. V<sub>OPEAK</sub> can be determined from Equation 5 and I<sub>OPEAK</sub> from Equation 6.

$$V_{OPEAK} = \sqrt{(2R_L P_O)}$$
 (5)

$$I_{OPEAK} = \sqrt{(2P_O)/R_L}$$
 (6)

To determine the maximum supply voltage the following conditions must be considered. Add the dropout voltage to the peak output swing  $V_{OPEAK}$ , to get the supply rail at a current of  $I_{OPEAK}$ . The regulation of the supply determines the unloaded voltage which is usually about 15% higher. The supply voltage will also rise 10% during high line conditions. Therefore the maximum supply voltage is obtained from the following equation.

Max supplies ≈ 
$$\pm$$
 (V<sub>OPEAK</sub> + V<sub>OD</sub>) (1 + regulation) (1.1) (7)

For 30W of output power into an  $8\Omega$  load, the required  $V_{OPEAK}$  is 21.91V. A minimum supply rail of 25.4V results from adding  $V_{OPEAK}$  and  $V_{OD}$ . With regulation, the maximum supplies are  $\pm 32$ V and the required  $I_{OPEAK}$  is 2.74A from Equation 6. It should be noted that for a dual 30W amplifier into an  $8\Omega$  load the  $I_{OPEAK}$  drawn from the supplies is twice 2.74A<sub>PK</sub> or 5.48A<sub>PK</sub>. At this point it is a good idea to check the Power Output vs Supply Voltage to ensure that the required output power is obtainable from the device while maintaining low THD+N. In addition, the designer should verify that with the required power supply voltage and load impedance, that the required heatsink value  $\theta_{SA}$  is feasible given system cost and size constraints. Once the heatsink issues have been addressed, the required gain can be determined from Equation 8.

$$A_{V} \ge \sqrt{(P_{O}R_{L})}/(V_{IN}) = V_{ORMS}/V_{INRMS}$$
(8)

From Equation 8, the minimum  $A_V$  is:  $A_V \ge 15.5$ .

By selecting a gain of 21, and with a feedback resistor,  $R_f = 20k\Omega$ , the value of  $R_i$  follows from Equation 9.

$$R_i = R_f (A_V - 1) \tag{9}$$

Thus with  $R_i = 1k\Omega$  a non-inverting gain of 21 will result. Since the desired input impedance was  $47k\Omega$ , a value of  $47k\Omega$  was selected for  $R_{IN}$ . The final design step is to address the bandwidth requirements which must be stated as a pair of -3dB frequency points. Five times away from a -3dB point is 0.17dB down from passband response which is better than the required  $\pm 0.25dB$  specified. This fact results in a low and high frequency pole of 4Hz and 100kHz respectively. As stated in the External Components Description section,  $R_i$  in conjunction with  $C_i$  create a high-pass filter.

$$C_i \ge 1/(2\pi * 1k\Omega * 4Hz) = 39.8\mu\text{F};$$
 use  $39\mu\text{F}.$  (10)

The high frequency pole is determined by the product of the desired high frequency pole,  $f_H$ , and the gain,  $A_V$ . With a  $A_V$  = 21 and  $f_H$  = 100kHz, the resulting GBWP is 2.1MHz, which is less than the ensured minimum GBWP of the LM4766 of 8MHz. This will ensure that the high frequency response of the amplifier will be no worse than 0.17dB down at 20kHz which is well within the bandwidth requirements of the design.



# **REVISION HISTORY**

Changes from Revision E (March 2013) to Revision #IMPLIED

Page



# PACKAGE OPTION ADDENDUM

10-Dec-2020

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
LM4766T/NOPB	ACTIVE	TO-220	NDL	15	20	RoHS & Green	SN	Level-1-NA-UNLIM	0 to 70	LM4766T	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

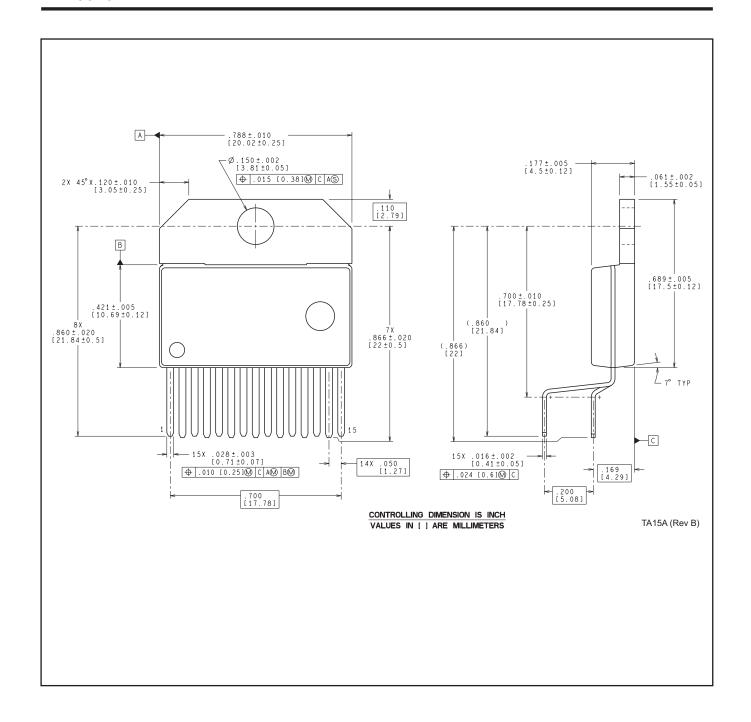
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.





#### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

Tl's products are provided subject to Tl's Terms of Sale (<a href="www.ti.com/legal/termsofsale.html">www.ti.com/legal/termsofsale.html</a>) or other applicable terms available either on ti.com or provided in conjunction with such Tl products. Tl's provision of these resources does not expand or otherwise alter Tl's applicable warranties or warranty disclaimers for Tl products.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2020, Texas Instruments Incorporated